

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	10/711,839	CHUNG, CHI-JUI
	<b>Examiner</b> DINH T. LE	<b>Art Unit</b> 2816

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
327	see above	11/4/2005	DL
377	see above	11/4/2005	DL